Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/541,517	TORNO ET AL.
Examiner	Art Unit

HIEU T. VO

SEARCHED					
Class	Subclass	Date	Examiner		
701	111 110 114	11/22/2008	/HV/		
123	406.21	11/22/2008	/HV/		
123	406.35	11/22/2008	/HV/		

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
,	DATE	EXMR		
EAST	11/22/200	08 /HV/		